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Application/Control No.	Applicant(s)/Patent under Reexamination
10/606,611	POLIAC ET AL.
Examiner	Art Unit
Dustin Nauven	2154

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Class	Subclass	Date	Examiner
709	203, 224	1/31/2007	DN
600	300	1/31/2007	DN
700	2	1/31/2007	DN
128	899	1/31/2007	DN
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Class	Subclass	Date	Examiner
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SEARCH (INCLUDING SEAF	NOTES CH STRATEGY	)
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